

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HASEI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0060518 a	05-2002	Duineveld et al.	313/506
	B	US-2002/0015800	02-2002	MIYAMOTO et al.	427/553
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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